

IEC SYSTEM FOR MUTUAL RECOGNITION OF TEST CERTIFICATES FOR ELECTRICAL EQUIPMENT
(IECEE) CB SCHEME

CB TEST CERTIFICATE

Product	Surface and Catalyst Characterization Analyzer
Name and address of the applicant	Micromeritics Instrument Corporation 4356 Communications Drive Norcross, GA 30093 United States of America
Name and address of the manufacturer	Micromeritics Instrument Corporation 4356 Communications Drive Norcross, GA 30093 United States of America
Name and address of the factory	<input type="checkbox"/> Additional information on page 2 Micromeritics Instrument Corporation 4356 Communications Drive Norcross, GA 30093 United States of America
Note: When more than one factory, please report on page 2	
Ratings and principal characteristics	100/120/230Vac, 50/60Hz, 1350VA
Trademark (if any)	mi micromeritics
Customer's Testing Facility (CTF) Stage used	
Model / Type Ref.	3Flex, Flex
Additional information (if necessary may also be reported on page 2)	<input type="checkbox"/> Additional information on page 2
A sample of the product was tested and found to be in conformity with	IEC 61010-1:2010/AMD1:2016, IEC 61010-2-010:2019, IEC 61010-2-081:2019
As shown in the Test Report Ref. No. which forms part of this Certificate	Comments: Refer to the test report for the summary of compliance with National Deviations 104494906ATL-001C, 104494906ATL-001D, 104494906ATL-001E

This CB Test Certificate is issued by the National Certification Body

Intertek Testing Services NA, Inc.
545 E. Algonquin Road, Suite F, Arlington Heights, IL 60005, United States of America

Date: 2021-04-15

Signature: John Quigley

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